SK60GAL125



SEMITOP® 2

IGBT Module

SK60GAL125 SK60GAR125

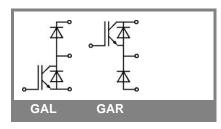
Target Data

Features

- Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- · High short circuit capability
- Ultra Fast NPT IGBT technology
- V_{ce,sat} with positive coefficient

Typical Applications*

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



| Absolute Maximum Ratings T _s = 25 °C, unless otherwise specific | | | | | | |
|--|--|-------------------------|--|------------------|-------|--|
| Symbol | Conditions | | | Values | Units | |
| IGBT | | | | | | |
| V_{CES} | T _j = 25 °C T _i = 125 °C | | | 1200 | V | |
| I _C | T _j = 125 °C | T _s = 25 °C | | 51 | Α | |
| | | T _s = 80 °C | | 35 | Α | |
| I _{CRM} | I _{CRM} = 2 x I _{Cnom} | | | 100 | Α | |
| V_{GES} | | | | ± 20 | ٧ | |
| t _{psc} | V_{CC} = 300 V; $V_{GE} \le 20$ V; $V_{CES} < 600$ V | T _j = 125 °C | | 10 | μs | |
| Inverse | Diode | | | | | |
| I _F | T _j = 150 °C | T_s = 25 °C | | 43 | Α | |
| | | T _s = 80 °C | | 29 | Α | |
| I _{FRM} | I _{FRM} = 2 x I _{Fnom} | | | | Α | |
| I _{FSM} | t _p = 10 ms; half sine wave | T _j = 25 °C | | 110 | Α | |
| Freewhe | eling Diode | | | | | |
| I _F | T _j = 150 °C | T_s = 25 °C | | 57 | Α | |
| | | T_s = 80 °C | | 38 | Α | |
| I _{FRM} | | | | | Α | |
| I _{FSM} | t _p = 10 ms; half sine wave | T _j = 150 °C | | 550 | А | |
| Module | | | | | | |
| I _{t(RMS)} | | | | | Α | |
| T _{vj} | | | | -40 + 150 | °C | |
| T _{stg} | | | | -40 + 125 | °C | |
| V _{isol} | AC, 1 min. | | | 2500 | V | |

| Characteristics T _s = 25 °C, unless otherwise specific | | | | | pecified | |
|--|--|---------------------------------|------|------|----------|-----------|
| Symbol | Conditions | | min. | typ. | max. | Units |
| IGBT | | | | | | |
| $V_{GE(th)}$ | $V_{GE} = V_{CE}$, $I_{C} = 2 \text{ mA}$ | | 4,5 | 5,5 | 6,5 | V |
| I _{CES} | V_{GE} = 0 V, V_{CE} = V_{CES} | T _j = 25 °C | | | 0,006 | mA |
| I _{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = 20 \text{ V}$ | T _j = 25 °C | | | 300 | nA |
| V_{CE0} | | T _j = 25 °C | | 1,4 | 1,9 | V |
| | | T _j = 125 °C | | 1,7 | 2,2 | V |
| r _{CE} | V _{GE} = 15 V | T _j = 25°C | | 36 | | mΩ |
| | | T _j = 125°C | | 43 | | $m\Omega$ |
| V _{CE(sat)} | I _{Cnom} = 50 A, V _{GE} = 15 V | | | 3,2 | 3,7 | V |
| | | $T_j = 125^{\circ}C_{chiplev.}$ | | 3,85 | | V |
| C _{ies} | | | | 3,3 | | nF |
| C _{oes} | $V_{CE} = 25, V_{GE} = 0 V$ | f = 1 MHz | | 0,5 | | nF |
| C _{res} | | | | 0,22 | | nF |
| t _{d(on)} | | | | | | ns |
| t _r | $R_{Gon} = 33 \Omega$ | V _{CC} = 600V | | 0.00 | | ns |
| E _{on} | D - 00 0 | I _C = 45A | | 8,36 | | mJ |
| t _{d(off)} | R_{Goff} = 33 Ω | T _j = 125 °C | | | | ns |
| t _f | | V _{GE} =±15V | | | | ns |
| E _{off} | | | | 3,32 | | mJ |
| $R_{th(j-s)}$ | per IGBT | | | | 0,6 | K/W |

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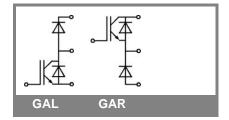
Typical Applications*

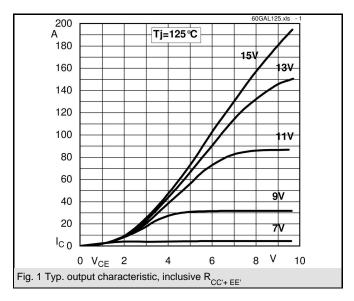
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- Inverter
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- UPS

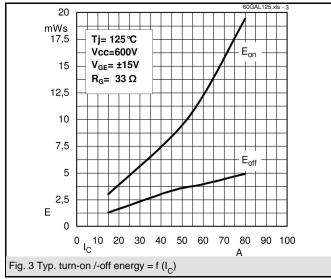
| Characteristics | | | | | | | | |
|-----------------------|---|---|------|------|------|-------|--|--|
| Symbol | Conditions | | min. | typ. | max. | Units | | |
| Inverse Diode | | | | | | | | |
| $V_F = V_{EC}$ | I_{Fnom} = 10 A; V_{GE} = 0 V | | | 2 | 2,5 | V | | |
| | | $T_j = 150 ^{\circ}C_{chiplev.}$ | | 1,79 | 2,3 | V | | |
| V_{F0} | | T _j = 25 °C | | | | V | | |
| | | T _j = 125 °C | | 1,18 | | V | | |
| r _F | | T _j = 25 °C | | | | mΩ | | |
| | | T _j = 125 °C | | 31,5 | | mΩ | | |
| I _{RRM} | I _F = 30 A | T _j = 125 °C | | | | Α | | |
| Q_{rr} | di/dt = -100 A/μs | | | | | μC | | |
| E _{rr} | V _{CC} = 400V | | | | | mJ | | |
| $R_{\text{th(j-s)D}}$ | per diode | | | | 1,16 | K/W | | |
| | Freewheeling Diode | | | | | | | |
| $V_F = V_{EC}$ | $I_{Fnom} = 50 \text{ A}; V_{GE} = 0 \text{ V}$ | $T_j = 25 ^{\circ}C_{\text{chiplev.}}$ | | 2 | 2,5 | V | | |
| | | $T_j = 125 ^{\circ}C_{chiplev.}$ | | 1,8 | | V | | |
| V_{F0} | | T _j = 125 °C | | 1 | 1,2 | V | | |
| r _F | | T _j = 125 °C | | 16 | 22 | V | | |
| I _{RRM} | I _F = 50 A | T _j = 125 °C | | | | Α | | |
| Q_{rr} | di/dt = -800 A/μs | | | | | μC | | |
| E _{rr} | V _R =600V | | | | | mJ | | |
| $R_{th(j-s)FD}$ | per diode | | | | 0,9 | K/W | | |
| M _s | to heat sink | | | | 2 | Nm | | |
| w | | | | 19 | | g | | |

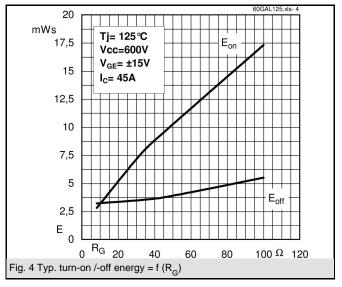
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

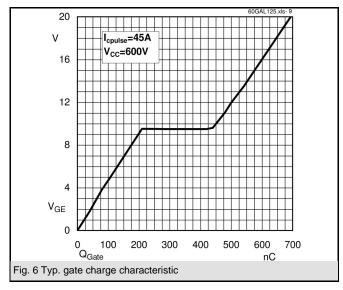
* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.











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